# MOSFET – Power, N-Channel 100 V, 17 A, 81 mΩ

# **NTD6416AN, NVD6416AN**

#### **Features**

- Low R<sub>DS(on)</sub>
- High Current Capability
- 100% Avalanche Tested
- NVD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

#### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	100	V
Gate-to-Source Voltag	ge – Conti	nuous	$V_{GS}$	±20	V
Continuous Drain	Steady State	T <sub>C</sub> = 25°C	I <sub>D</sub>	17	Α
Current	State	T <sub>C</sub> = 100°C		11	
Power Dissipation	Steady State	T <sub>C</sub> = 25°C	P <sub>D</sub>	71	W
Pulsed Drain Current	t <sub>p</sub>	= 10 μs	I <sub>DM</sub>	62	Α
Operating and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C
Source Current (Body Diode)			I <sub>S</sub>	17	Α
Single Pulse Drain-to-Source Avalanche Energy ( $V_{DD}$ = 50 Vdc, $V_{GS}$ = 10 Vdc, $I_{L(pk)}$ = 17 A, L = 0.3 mH, $R_G$ = 25 $\Omega$ )			E <sub>AS</sub>	43	mJ
Lead Temperature for Soldering Purposes, 1/8" from Case for 10 Seconds			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Case (Drain) Steady State	$R_{\theta JC}$	2.1	°C/W
Junction-to-Ambient (Note 1)	$R_{\theta JA}$	40	

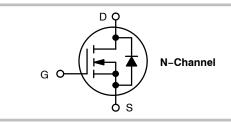
1. Surface mounted on FR4 board using 1 sq in pad size, (Cu Area 1.127 sq in [2 oz] including traces).



#### ON Semiconductor®

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V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX (Note 1)
100 V	81 mΩ @ 10 V	17 A



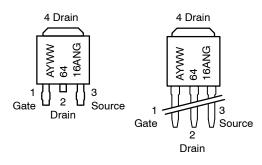




DPAK CASE 369AA STYLE 2

IPAK CASE 369D STYLE 2

# MARKING DIAGRAM & PIN ASSIGNMENTS



A = Assembly Location\*

Y = Year

WW = Work Week

6416AN = Device Code

G = Pb-Free Package

\* The Assembly Location code (A) is front side optional. In cases where the Assembly Location is stamped in the package, the front side assembly code may be blank.

#### ORDERING INFORMATION

See detailed ordering and shipping information on page 5 of this data sheet.

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							•
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		100			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				112		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C			1.0	μΑ
		V <sub>DS</sub> = 100 V	T <sub>J</sub> = 125°C			10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> =	±20 V			±100	nA
ON CHARACTERISTICS (Note 3)	•				•		
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = 2$	250 μΑ	2.0		4.0	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				7.7		mV/°C
Drain-to-Source On-Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> =	17 A		73	81	mΩ
Forward Transconductance	9FS	V <sub>DS</sub> = 5 V, I <sub>D</sub> =	10 A		12		S
CHARGES, CAPACITANCES AND GAT	E RESISTANO	CE	•		•		•
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz, V <sub>DS</sub> = 25 V			620		pF
Output Capacitance	C <sub>OSS</sub>				110		
Reverse Transfer Capacitance	C <sub>RSS</sub>				50		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 80 V, I <sub>D</sub> = 17 A			20		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				1.0		
Gate-to-Source Charge	Q <sub>GS</sub>				3.6		
Gate-to-Drain Charge	$Q_{GD}$				10		
Plateau Voltage	$V_{GP}$				5.8		V
Gate Resistance	$R_{G}$				2.4		Ω
SWITCHING CHARACTERISTICS (Not	e 4)						-
Turn-On Delay Time	t <sub>d(on)</sub>				9.2		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V, V <sub>DD</sub>	= 80 V,		22		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D = 17 \text{ A}, R_G =$	6.1 Ω <sup>′</sup>		24		
Fall Time	t <sub>f</sub>				20		
DRAIN-SOURCE DIODE CHARACTEF	RISTICS						
Forward Diode Voltage	V <sub>SD</sub>	., .,,,	T <sub>J</sub> = 25°C		0.85	1.2	V
		$V_{GS} = 0 \text{ V, } I_S = 17 \text{ A}$ $T_J = 125^{\circ}\text{C}$			0.7		1
Reverse Recovery Time	t <sub>rr</sub>				56		ns
Charge Time	ta	$V_{GS} = 0 \text{ V, dI}_{S}/\text{dt} = 0$	100 A/μs.		41		1
Discharge Time	t <sub>b</sub>	l <sub>S</sub> = 17 A			15		1
Reverse Recovery Charge	Q <sub>RR</sub>				135		nC

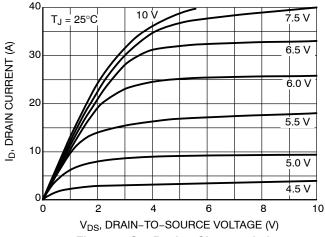
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

2. Surface mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).

3. Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.

4. Switching characteristics are independent of operating junction temperatures.

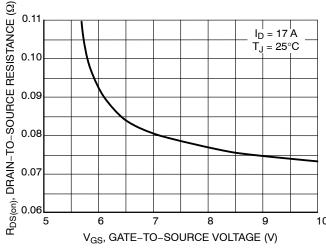
#### **TYPICAL CHARACTERISTICS**



40  $V_{DS} \ge 10 V$ 35 ID, DRAIN CURRENT (A) 30 25 20 15 = 25°C 10 125°C 5  $T_{J}' = -55^{\circ}C$ οL 2 3 6 8 V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (V)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



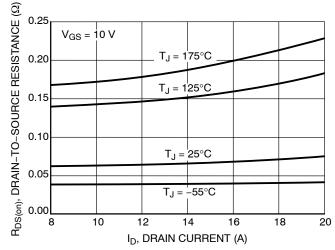
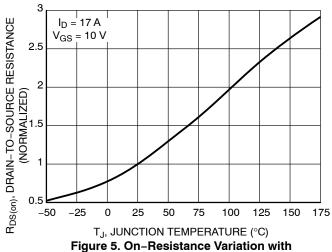


Figure 3. On-Region versus Gate Voltage

Figure 4. On-Resistance versus Drain Current and Gate Voltage



**Temperature** 

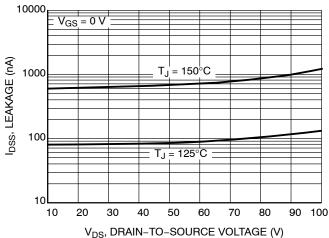
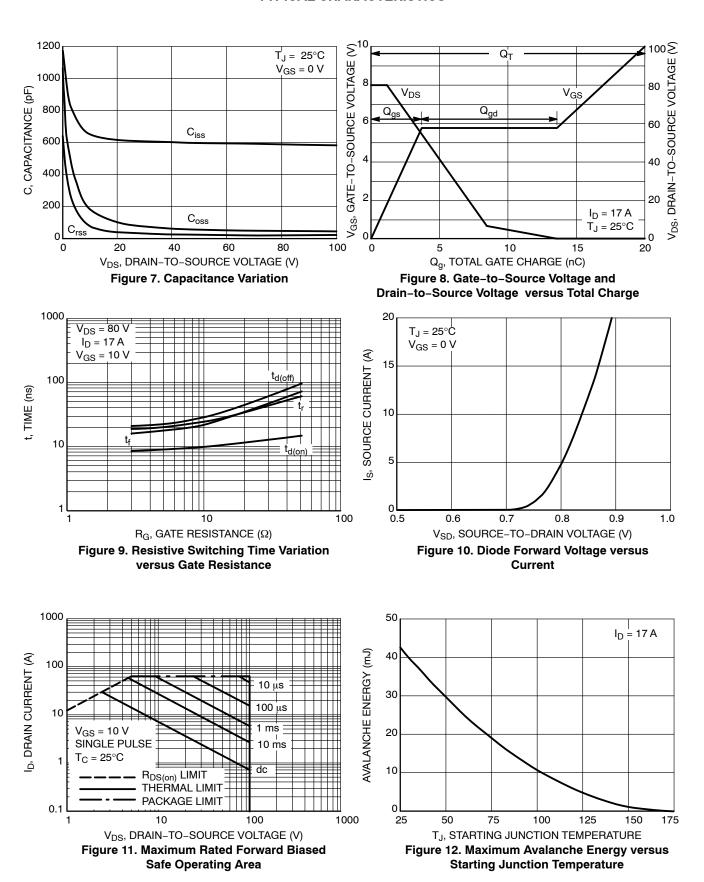


Figure 6. Drain-to-Source Leakage Current versus Voltage

#### **TYPICAL CHARACTERISTICS**



#### **TYPICAL CHARACTERISTICS**

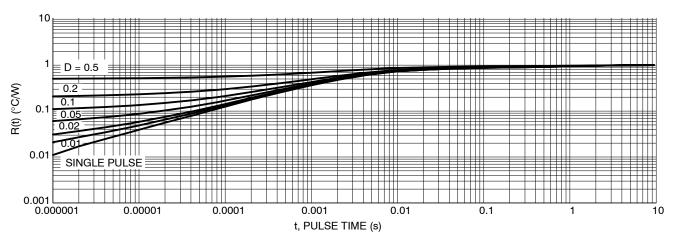


Figure 13. Thermal Response

#### **ORDERING INFORMATION**

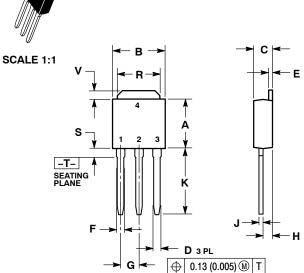
Device	Package	Shipping†
NTD6416ANT4G	DPAK (Pb-Free)	2500 / Tape & Reel
NTD6416AN-1G	IPAK (Pb-Free)	75 Units / Rail
NVD6416ANT4G*	DPAK (Pb-Free)	2500 / Tape & Reel
NVD6416ANT4G-VF01*	DPAK (Pb-Free)	2500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

<sup>\*</sup>NVD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable.



**DATE 15 DEC 2010** 



STYLE 2:

PIN 1. GATE

3

STYLE 6: PIN 1. MT1 2. MT2 3. GATE

2. DRAIN

4. DRAIN

MT2

SOURCE

STYLE 1: PIN 1. BASE

3

STYLE 5: PIN 1. GATE

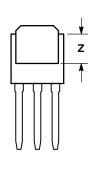
2. ANODE 3. CATHODE

ANODE

2. COLLECTOR

**EMITTER** 

COLLECTOR



#### NOTES:

- DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
E	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090	BSC	2.29 BSC	
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
٧	0.035	0.050	0.89	1.27
Z	0.155		3.93	

#### **MARKING DIAGRAMS**

STYLE 4: PIN 1. CATHODE

STYLE 3: PIN 1. ANODE

2. CATHODE

4. CATHODE

3 ANODE

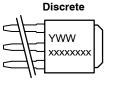
STYLE 7: PIN 1. GATE 2. COLLECTOR

3. EMITTER

COLLECTOR

ANODE
 GATE

4. ANODE





xxxxxxxxx = Device Code = Assembly Location IL = Wafer Lot

Υ = Year WW = Work Week

DOCUMENT NUMBER:	98AON10528D	Electronic versions are uncontrolled except when accessed directly from Printed versions are uncontrolled except when stamped "CONTROLLED	
DESCRIPTION:	IPAK (DPAK INSERTION MOUNT)		PAGE 1 OF 1

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## **DPAK (SINGLE GUAGE)** CASE 369AA-01 **ISSUE B** SCALE 1:1 C Α В z

DETAIL A

0.005 (0.13) M C

#### **DATE 03 JUN 2010**

#### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: INCHES.
  3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z.
  4. DIMENSIONS D AND E DO NOT INCLUDE MOLD
- FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE
- DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.030	0.045	0.76	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
Е	0.250	0.265	6.35	6.73
е	0.090	BSC	2.29 BSC	
Н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.108 REF		2.74	REF
L2	0.020 BSC		0.51	BSC
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	

# L2 GAUGE C SEATING PLANE **DETAIL A** ROTATED 90° CW



PIN 1. GATE 2. ANODE 3. CATHODE

4. ANODE

STYLE 5:

b2



h  $\oplus$ 

STYLE 3: PIN 1. ANODE 2. CATHODE 3. ANODE CATHODE

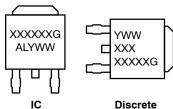
COLLECTOR

STYLE 4: PIN 1. CATHODE 2. ANODE 3. GATE

Н

STYLE 6: STYLE 7: PIN 1. GATE 2. COLLECTOR PIN 1. MT1 2. MT2 3. GATE 3. EMITTER

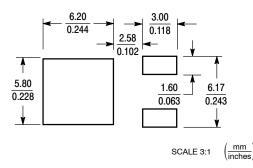
#### **GENERIC** MARKING DIAGRAM\*



XXXXXX = Device Code Α = Assembly Location L = Wafer Lot ٧ = Year = Work Week WW = Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking.

#### **SOLDERING FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

DOCUMENT NUMBER:	98AON13126D	Electronic versions are uncontrolled except when accessed directly from Printed versions are uncontrolled except when stamped "CONTROLLED"	
DESCRIPTION:	DPAK (SINGLE GAUGE)		PAGE 1 OF 1

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